

Features

- Uses CRM(CQ) advanced Trench technology
- Extremely low on-resistance $R_{DS(on)}$
- Excellent $Q_g \times R_{DS(on)}$ product(FOM)

Product Summary

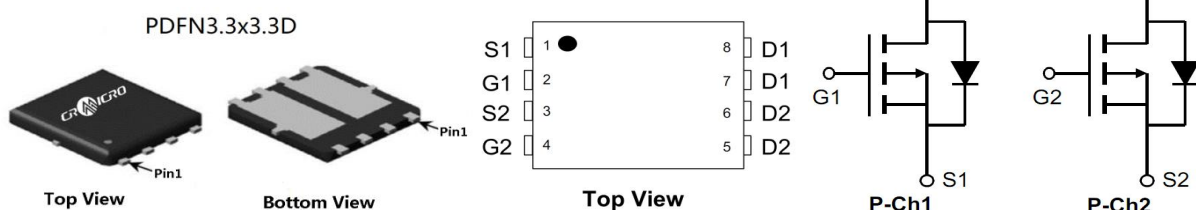
Symbol	P-Ch1	P-Ch2
V_{DS}	-30V	-30V
$R_{DS(on)}$ typ.	20m Ω	20m Ω
I_D	-16A	-16A

Applications

- Motor drive

100% DVDS Tested

100% Avalanche Tested



Package Marking and Ordering Information

Part #	Marking	Package	Packing	Reel Size	Tape Width	Qty
CRMB0322D	B0322D	PDFN3.3x3.3D	Taping	N/A	N/A	5000pcs

Absolute Maximum Ratings

Parameter	Symbol	Maximum		Unit
		P-Ch1	PCh2	
Drain-source voltage	V_{DS}	-30	-30	V
Continuous drain current $T_C = 25^\circ\text{C}$ (Silicon limit)	I_D	-20	-20	A
Continuous drain current $T_C = 25^\circ\text{C}$ (Package limit)	I_D	-16	-16	A
Pulsed drain current ($T_C = 25^\circ\text{C}$, t_p limited by T_{jmax})	$I_{D\ pulse}$	-64	-64	A
Avalanche energy, single pulse ($L=0.5\text{mH}$, $R_g=25\Omega$)	E_{AS}	81	81	mJ
Gate-Source voltage	V_{GS}	± 20	± 20	V
Power dissipation ($T_C = 25^\circ\text{C}$)	P_{tot}	14.5	14.5	W
Operating junction and storage temperature	T_j, T_{stg}	-55...+150		$^\circ\text{C}$

Thermal Resistance

Parameter	Symbol	Typ	Max	Unit
Thermal resistance, junction – case.	R_{thJC}	7.2	8.6	$^{\circ}\text{C}/\text{W}$
SMD version, device on PCB ¹	R_{thJA}	76.0	91.2	$^{\circ}\text{C}/\text{W}$
Thermal resistance, junction – ambient(min. footprint)				

NOTE:

1.The value of R_{thJA} is measured with the device mounted on 1in2 FR-4 board with 2oz. Copper, in a still air environment with $T_A = 25^{\circ}\text{C}$. The value in any given application depends on the user's specific board design.

P-Ch1&P-Ch2 Electrical Characteristic (at $T_J = 25^{\circ}\text{C}$, unless otherwise specified)

Parameter	Symbol	Value			Unit	Test Condition
		min.	typ.	max.		

Static Characteristic

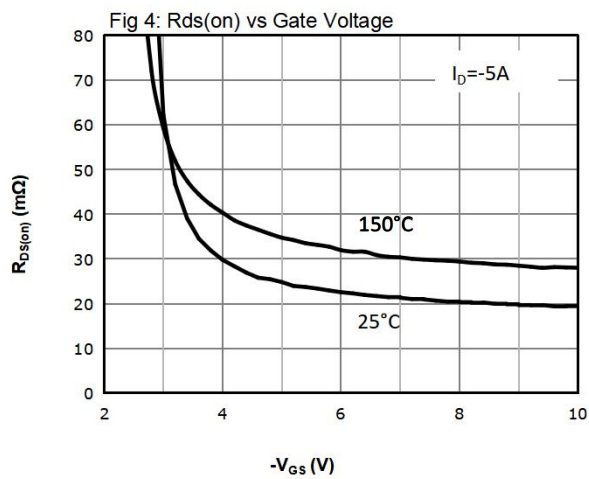
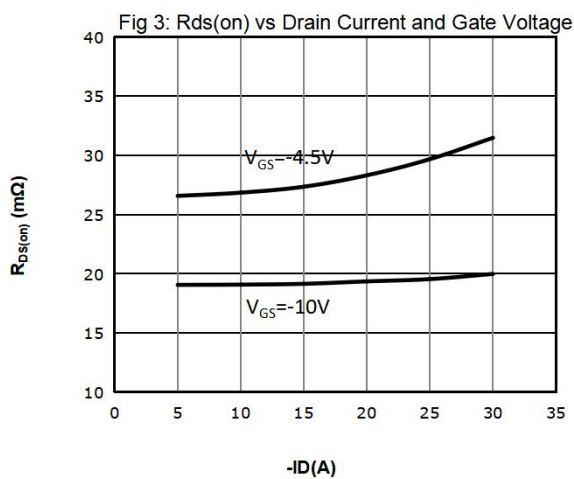
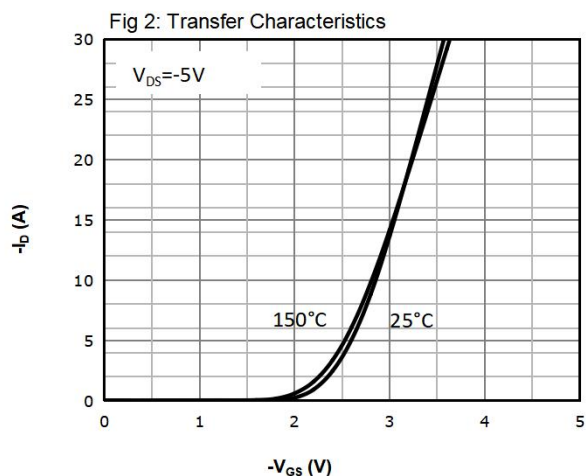
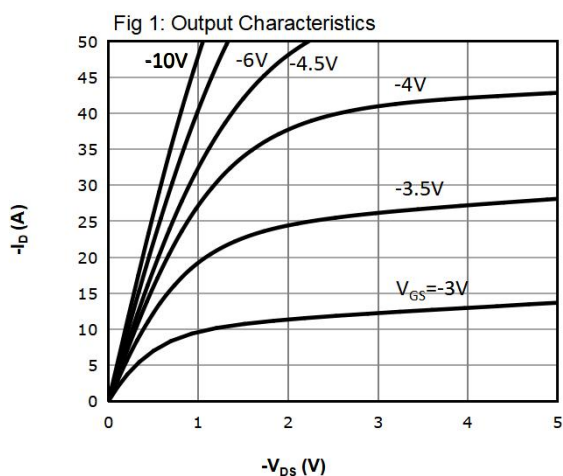
Drain-source breakdown voltage	BV_{DSS}	-30	-	-	V	$V_{GS}=0V, I_D=-250\mu\text{A}$
Gate threshold voltage	$V_{GS(th)}$	-1	-1.6	-2.2	V	$V_{DS}=V_{GS}, I_D=-250\mu\text{A}$
Zero gate voltage drain current	I_{DSS}	-	-0.1	-1	μA	$V_{DS}=-30V, V_{GS}=0V$ $T_J=25^{\circ}\text{C}$
		-	-	-5		$T_J=125^{\circ}\text{C}$
Gate-source leakage current	I_{GSS}	-	± 10	± 100	nA	$V_{GS}=\pm 20V, V_{DS}=0V$
Drain-source on-state resistance	$R_{DS(on)}$	-	27.0	36.0	m Ω	$V_{GS}=-4.5V, I_D=-5A$
		-	20.0	26.0		$V_{GS}=-10V, I_D=-5A$
Transconductance	g_{fs}	-	15.5	-	S	$V_{DS}=-5V, I_D=-5A$

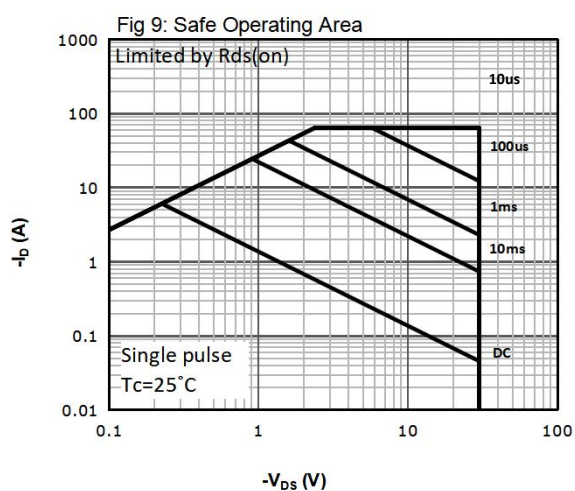
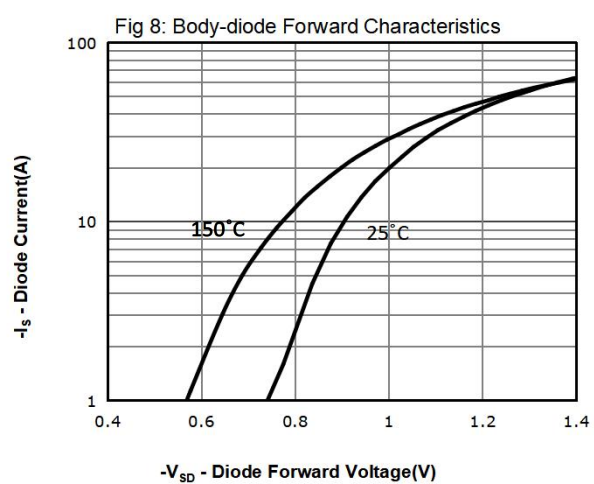
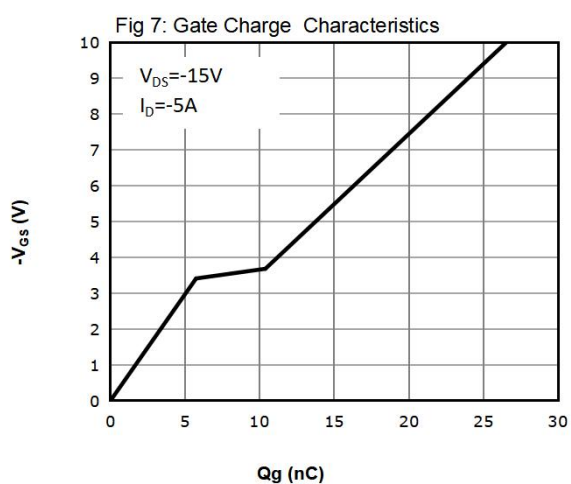
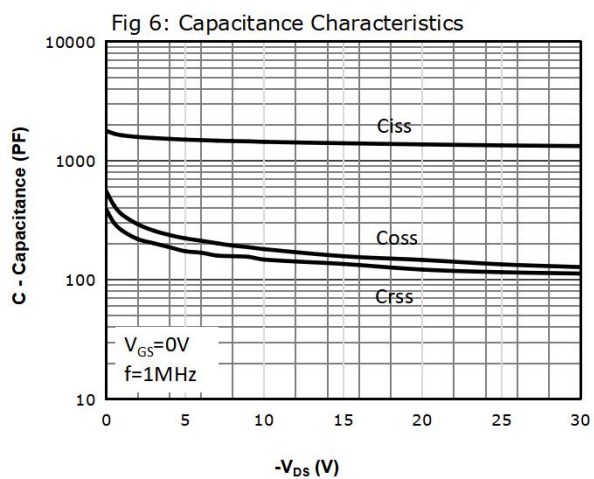
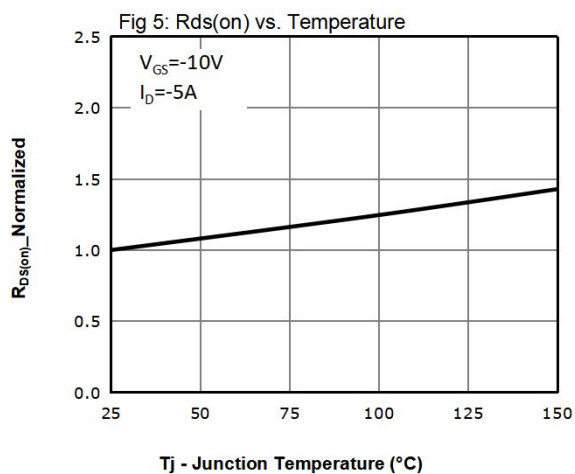
Dynamic Characteristic

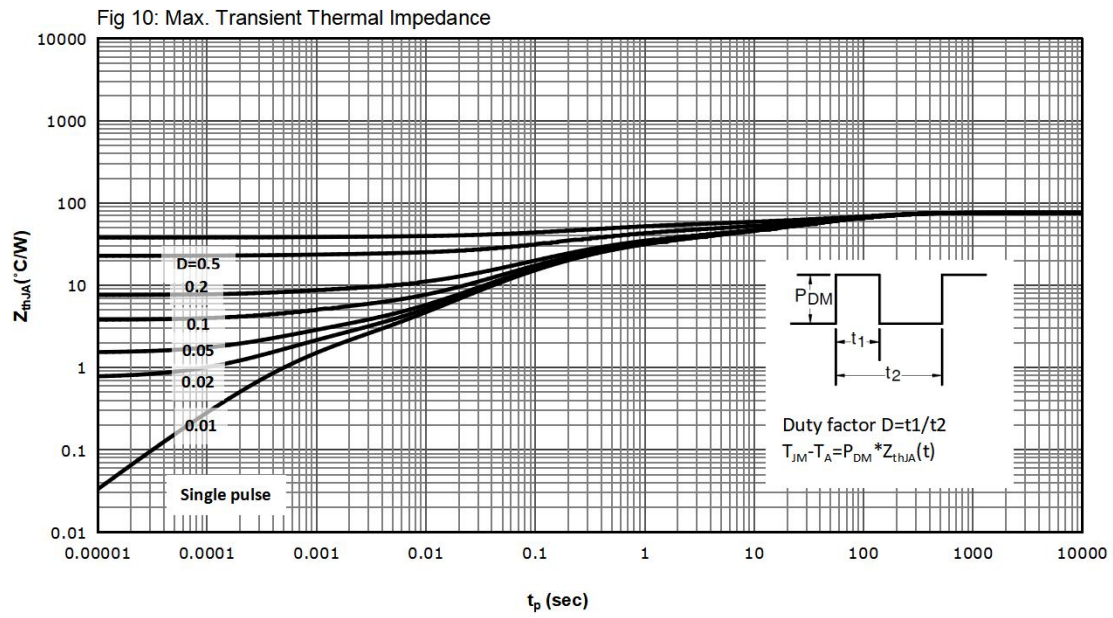
Input Capacitance	C_{iss}	-	1400	-	pF	$V_{GS}=0V, V_{DS}=-15V, f=1\text{MHz}$
Output Capacitance	C_{oss}	-	158	-		
Reverse Transfer Capacitance	C_{rss}	-	136	-		
Gate Total Charge	Q_G	-	26.5	-	nC	$V_{GS}=-10V, V_{DS}=-15V,$ $I_D=-5A, f=1\text{MHz}$
Gate-Source charge	Q_{gs}	-	5.74	-		
Gate-Drain charge	Q_{gd}	-	4.6	-		
Turn-on delay time	$t_{d(on)}$	-	7.6	-	ns	$V_{GS}=-10V, V_{DD}=-15V,$ $R_{G_ext}=2.7\Omega, I_D=-5A$
Rise time	t_r	-	26.9	-		
Turn-off delay time	$t_{d(off)}$	-	37.9	-		
Fall time	t_f	-	34.5	-		
Gate resistance	R_G	-	6.7	-	Ω	$V_{GS}=0V, V_{DS}=0V, f=1\text{MHz}$

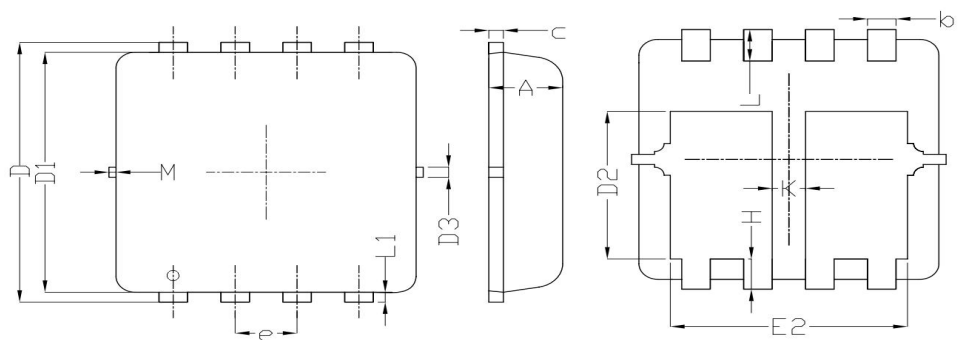
Body Diode Characteristic

Parameter	Symbol	Value			Unit	Test Condition
		min.	typ.	max.		
Body Diode Forward Voltage	V_{SD}	-	-0.85	-1.20	V	$V_{GS}=0V, I_{SD}=-5A$
Body Diode Reverse Recovery Time	t_{rr}	-	13.3	-	ns	$I_F=-5A, dI/dt=100A/\mu s$
Body Diode Reverse Recovery Charge	Q_{rr}	-	5.8	-	nC	

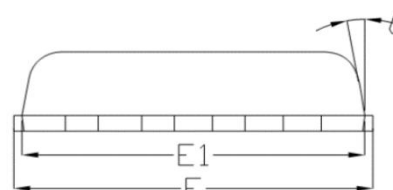
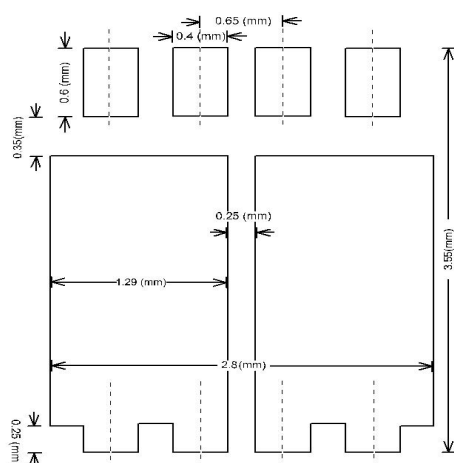
P-Ch1&P-Ch2 Typical Performance Characteristics






Package Outline: PDFN3.3x3.3D


Land Pattern
(Only For Reference)



UNIT: mm

SYMBOLS	DIMENSIONS IN MILLIMETERS			DIMENSIONS IN INCHES		
	MIN	NOM	MAX	MIN	NOM	MAX
A	0.70	0.75	0.80	0.028	0.030	0.031
b	0.25	0.30	0.35	0.010	0.012	0.014
c	0.10	0.15	0.25	0.004	0.006	0.010
D	3.25	3.35	3.45	0.128	0.132	0.136
D1	3.00	3.10	3.20	0.118	0.122	0.126
D2	1.78	1.88	1.98	0.070	0.074	0.078
D3	----	0.13	----	----	0.005	----
E	3.20	3.30	3.40	0.126	0.130	0.134
E1	3.00	3.15	3.20	0.118	0.124	0.126
E2	2.39	2.49	2.59	0.094	0.098	0.102
e	0.65 BSC			0.026 BSC		
H	0.30	0.39	0.50	0.012	0.015	0.020
L	0.30	0.40	0.50	0.012	0.016	0.020
L1		0.13		----	0.005	----
K	0.30	----	----	0.012	----	----
θ	0°	----	12°	0°	----	12°
M	----	----	0.15	----	----	0.006

Note:

1. All Dimension Are In mm.
2. Package Body Sizes Exclude Mold Flash,Protrusion Or Gate Burrs.
Mold Flash,Protrusion Or Gate Burrs Shall Not Exceed 0.10 mm Per Side.
3. Package Body Sizes Determined At The Outermost Extremes Of The Plastic Body
Exclusive Of Mold Flash,Tie Bar Burrs,Gate Burrs And Interlead Flash,
But Including Any Mismatch Between The Top And Bottom Of The Plastic Body.

Revision History

Revision	Date	Major changes
1.0	2022/12/28	Release of formal version

Disclaimer

Unless otherwise specified in the datasheet, the product is designed and qualified as a standard commercial product and is not intended for use in applications that require extraordinary levels of quality and reliability, such as automotive, aviation/aerospace and life-support devices or systems.

Any and all semiconductor products have certain probability to fail or malfunction, which may result in personal injury, death or property damage. Customer are solely responsible for providing adequate safe measures when design their systems.

This product is suitable for reflow soldering up to 260°C, not very suitable for wave soldering.

The reliability of this product is not guaranteed under specific conditions when accepted by customers.

CRM(CQ) reserves the right to improve product design, function and reliability without notice.